

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/018,312	MICHEL ET AL.
Examiner	Art Unit	
Jacob Meek	2637	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	354, 145	1/19/2006	JM
370	350,335	1/19/2006	JM